

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
			Examiner Anne Marie M Boehler	Art Unit 3611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0040067	11-2001	Murakami et al.	180/444
	B	US-2004/0245040	12-2004	Eda et al.	180/444
	C	US-6,634,103	10-2003	Muraki et al.	29/898.07
	D	US-2004/0163879	08-2004	Segawa, Toru	180/444
	E	US-2002/0017420	02-2002	Kinme et al.	180/444
	F	US-2001/0002630	06-2001	Watanabe et al.	180/444
	G	US-6,823,962	11-2004	Iwasa et al.	180/444
	H	US-6,763,738	07-2004	Tsutsui et al.	74/388PS
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.